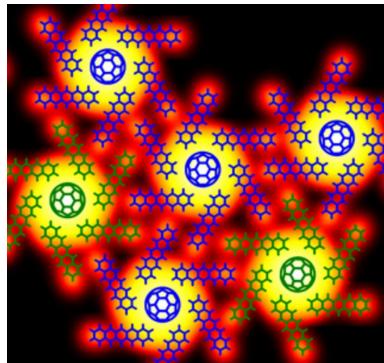


Group Members

Saw Wai Hla (Group Leader), shla@anl.gov
 - LT-STM, SP-STM, AFM
 Anand Bhattacharya, anand@anl.gov,
 - oxide MBE
 Seth Darling, darling@anl.gov
 - solar energy, organic PV, AFM, QEMs
 Brandon Fisher, fisher@anl.gov,
 - magnetometry, STM/SEM, XRD
 Jeffrey Guest, jrguest@anl.gov
 - STM, AFM, ultrafast microscopy
 Nathan Guisinger, nguisinger@anl.gov
 - STM, AFM, graphene
 Xiao-Min Lin, xmlin@anl.gov
 - synthesis of nanocrystal building blocks
 Dan Rosenmann, rosenmann@anl.gov
 - evaporation, deposition, sputtering, MBE

Electronic & Magnetic Materials & Devices



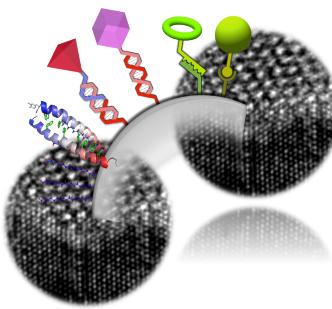
Major Tools

- UHV SPM (AFM/STM) (Omicron Nanotechnology)
- 4-probe SEM (Omicron UHV Nanoprobe)
- VT-AFM (Omicron XA), LT-STM
- Scanning probe microscope, AFM (Veeco)
- Complex Oxide MBE (DCA R450D Custom)
- Kurt Lesker electron beam evaporator and sputtering, deposition
- Magnetometry (QD PPMS & MPMS)
- Solar simulator, QEMs (Oriel)
- TGA/DSC
- Luminescence/UV-vis-NIR
- X-ray diffractometer (Bruker D2 & D8)

Group Members

Tijana Rajh (Group Leader), rajh@anl.gov
 - EPR, quantum dots, semiconductor-bio composites, LSCM
 Chris Fry, hfry@anl.gov
 - synthesis, peptide synthesis, HPLC, CD
 Yuzi Liu, yuziliu@anl.gov
 - analytical TEM
 Elena Rozhkova, rozhkova@anl.gov
 - bio(in)organic, biological chemistry, synthetic biology, GC/MS
 Elena Shevchenko, eshevchenko@anl.gov
 - 2-D and 3-D nanoparticle assembly, SEM

NanoBio Interfaces



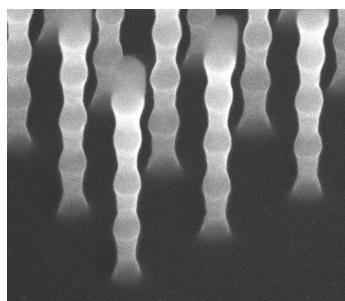
Major Tools

- Field-emission TEM (JEOL 2100F)
- Field-emission SEM (JEOL JSM7500F)
- Electron paramagnetic resonance (Bruker)
- Circular dichroism spectrometry
- Functionalization, electro/photochemical
- HPLC, GCMS
- Laser Scanning Confocal Microscope (Zeiss)
- Post-self-assembly processing
- Schlenk lines
- Solvent purification
- Peptide synthesizer
- Synthesis & surface modification of nanoparticles
- ZetaSizer Nano, Malvern

Group Members

Daniel Lopez (Group Leader), dlopez@anl.gov
 - MEMS/NEMS technology
 David Czaplewski, dczaplewski@anl.gov
 - MEMS/NEMS, ICP CVD
 Ralu Divan, divan@anl.gov
 - lithography, nanogels, MEMS/NEMS
 C. Suzanne Miller, csmiller@anl.gov
 - dicing saw, Karl Suss aligner
 Leo Ocola, ocola@anl.gov
 - nanofabrication, electron beam lithography
 Liliana Stan, istan@anl.gov
 - ALD, PVD, sputtering, evaporation
 Anirudha Suman, sumant@anl.gov
 - diamond-based NEMS, CNT, graphene
Il Woong Jung, ijung@anl.gov
 - focused ion beam lithography

Nanofabrication & Devices



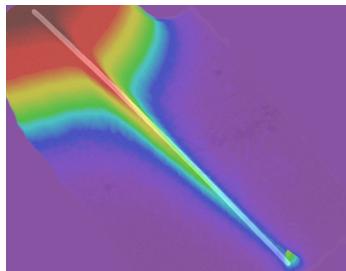
Major Tools

- JEOL 9300, 100kV electron beam lithography
- Raith 150, 30kV electron beam lithography
- FEI Nova 600 NanoLab DualBeam FIB/SEM
- Karl Suss MA6 Optical mask aligner
- Nanonex NX-3000 Nanoimprint
- Direct write optical lithography
- Interferometric lithography
- AJA oxide sputtering
- Wet chemistry & metrology
- SPM, PSIA XE-HDD
- Deposition (ebeam evaporator and sputtering, Sundew ALD, MOCVD)
- Lambda microwave plasma CVD nanocrystalline diamond
- Thermal/PECVD for CNT/graphene synthesis

Group Members

Gary Wiederrecht (Group Leader), wiederrecht@anl.gov
 - microscopy below diffraction limit, UTAS
Zhe Fei, zfei@anl.gov
 - 2-D materials, nano-imaging techniques
David Gosztola, gosztola@anl.gov
 - lasers, Raman, near-IR, NSOM
Richard Schaller, schaller@anl.gov
 - transient absorption/emission spectroscopy
Yugang Sun, ygsun@anl.gov
 - synthesis/fab of functional nanomaterials
 - optical, electronic, mechanical properties

Nanophotonics



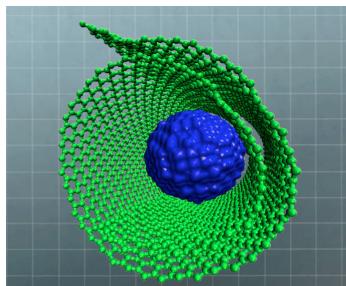
Major Tools

- NSOM
- Colloidal synthesis
- Confocal Raman microscope, Renishaw
- Time-correlated single photon counting
- Ultrafast transient absorption spectroscopy
- Ultrafast microscope
- FTIR (Thermo-Nicolet)
- VIS/NIR microscopy
- Nanolog spectrofluorimeter

Group Members

Stephen Gray (Group Leader), gray@anl.gov
 - nanophotonics, electrodynamics
Maria Chan, mchan@anl.gov
 - photovoltaics, photocatalysts,
 thermoelectrics, batteries
Pierre Darancet, pdarancet@anl.gov
 - photovoltaics, optical transport
Michael Sternberg, sternberg@anl.gov
 - software development
Subramanian Sankaranarayanan,
 - ssankaranarayanan@anl.gov
 - nanoscale oxide energy materials

Theory & Modeling



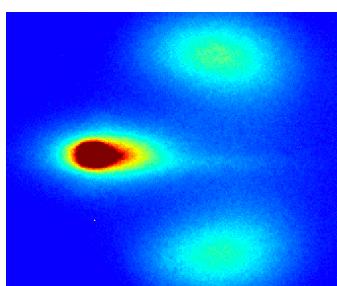
Major Tools

- Nanoscience Computational Facility
 30 TFlop cluster for:
 Density-functional-based tight-binding
 (DFTB) electronic structure package
 Time-domain nanophotonics simulation
 MPI-based parallel versions of
 nanophotonics and tight-binding codes
 GPAW; real space, grid-based DFT-PAW
- Access to Argonne computer facilities
- Support for experimental projects
- Support for theoretical projects

Group Members

Ian McNulty (Group Leader), mcnulty@anl.gov
 - diffraction, holography, x-ray microscopy,
 optics
Martin Holt, mvholt@anl.gov
 - x-ray diffraction and fluorescence
Volker Rose, vrose@anl.gov
 - synchrotron x-ray scanning tunneling
 microscopy
Robert Winarski, winarski@anl.gov
 - x-ray imaging and tomography

X-ray Microscopy



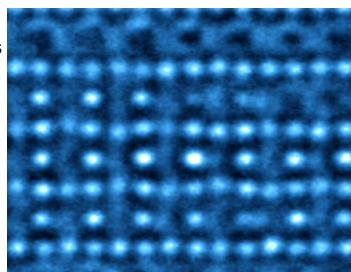
Major Tools

- Hard X-ray nanoprobe beamline, sector 26
 of APS
- Scanning probe X-ray diffraction microscopy
- Scanning probe X-ray fluorescence microscopy
- Full-field two-dimensional transmission imaging
 and tomography
- Heating/cooling specimen stage
- 30 – 50 nm resolution, 8 - 12 keV
- In situ/in operando experiments
- Synchrotron x-ray STM (SX-STM) in development

Group Members

Dean Miller (Group Leader), miller@anl.gov
 - oxide thin film and self-assembled synthesis
Rachel Koritala, koritala@anl.gov
 - SEM/TEM trainer
Jianguo Wen, jwen@anl.gov
 - ACAT, batteries, PV
Nestor Zaluzec, zaluzec@aaem.amc.anl.gov
 - transmission, scanning transmission, and
 analytical electron microscopy (FEI Tecnai)

Electron Microscopy Center



Major Tools

- ACAT: Argonne Chromatic Aberration-corrected TEM
- FEI Tecnai F20ST TEM/STEM
- Zeiss 1540XB FIB-SEM
- FEI CM30T, analytical transmission electron microscope
- Hitachi S-4700-II high-vacuum SEM
- FEI Quanta 400F environmental and variable-pressure SEM